Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | ITOW ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| | Α | US-5,469,646 | 11-1995 | Takamura, Fujitoshi | 60/428 |
| | В | US-5,752,214 | 05-1998 | Minowa et al. | 701/111 |
| | С | US-6,148,257 | 11-2000 | Katakura et al. | 701/54 |
| | D | US-6,564,172 | 05-2003 | Till, Ronald Herman | 702/182 |
| | E | US- | | · | |
| | F | US- | | | |
| | G | US- | | | |
| | Н | US- | | | |
| | 1 | US- | | | |
| | J | US- | | | |
| | к | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | | |
|---|---|---|--|--|--|--|
| | J | · | | | | |
| | > | | | | | |
| | W | | | | | |
| | × | | | | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.